

Notice of References Cited	Application/Control No. 09/841,666	Applicant(s)/Patent Under Reexamination TANAKA ET AL.
	Examiner HOAN C. NGUYEN	Art Unit 2871

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5534208	07-1996	Barr et al.	264/160
B	US-4911096	03-1990	Munakata	116/334
C	US-6513414	02-2003	Denney et al.	83/874
D	US-5804300	09-1998	Maro et al.	428/335
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K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP408071801A	03-1996	JP	Takeda et al.	
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S					
T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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